

ID	R _{Ds} (ON)(Typ)	VDSS
75A	17mΩ	200V
• 100% :	s: witching speed avalanche tested ved dv/dt capability	

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS75N20T	T0-220	RS75N20T	Tube	50 PCS

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	RS75N20T	Units
VDSS	Drain-to-Source Voltage	200	V
ID	Continuous Drain Current TC=25°C	75	А
IDM	Pulsed Drain Current	300	A
PD	Power Dissipation	330	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L =10mH,VDD = 50V, RG =25Ω, Tj = 25℃	1100	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS75N20T	Units	Test Conditions
RθJC	Junction-to-Case	0.45	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\!C$
RθJA	Junction-to- Ambient	62		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown Voltage	200			V	VGS=0V,ID=250μ Α
IDSS	Drain- to- Source Leakage Current			1.0	μA	VDS=200V,VGS= 0V
	Gate- to- Source Forward Leakage			100	- 4	VGS=20V ,VDS=0 V
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-20V ,VDS= 0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance		17	20	mΩ	VGS=10V,ID=35A
VGS(TH)	Gate Threshold Voltage	2.5		4.5	V	VGS=VDS,ID=25 0μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		25		- nS	VDS=100V ID=35A RG=10Ω
trise	Rise Time		16			
td(OFF)	Turn- OFF Delay Time		40			
tfall	Fall Time		11			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance (10V)		3300			VGS= 0V
Coss	Output Capacitance (4.5V)		200		pF	VDS=100V
Crss	Reverse Transfer Capacitance		13			f=1.0MHz
Qg	Total Gate Charge		40			VDS=100V
Qgs	Gate- to- Source Charge		16		nC	ID=35A VGS=10V
Qgd	Gate-to-Drain(" Miller") Charge		6			

Source- Drain Diode Characteristics

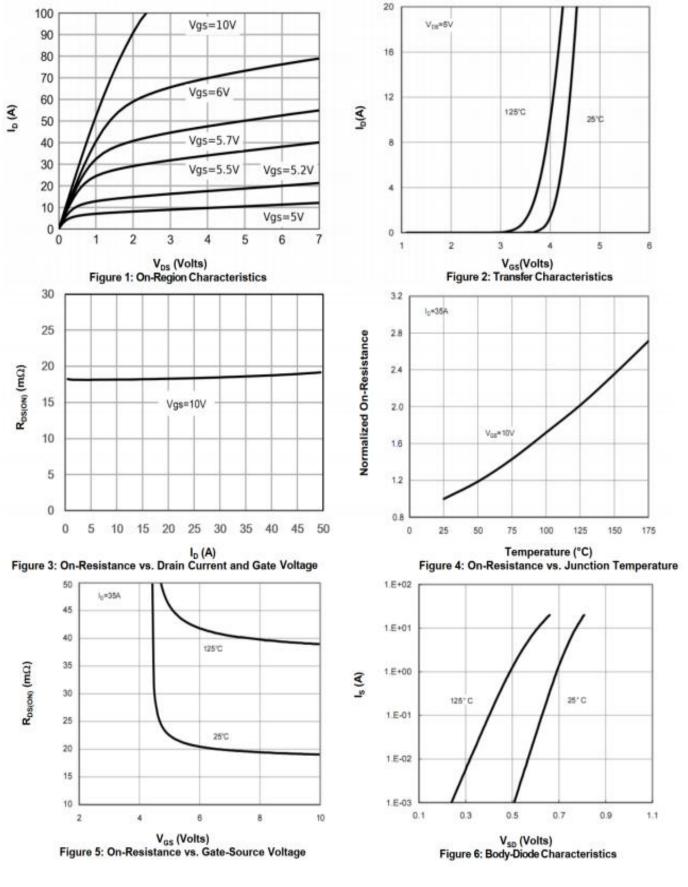
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			75	А	Integral pn- diode	
ISM	Maximum Pulsed Current			300	А	in MOSFET	
VSD	Diode Forward Voltage			1.2	V	IS=35A,VGS=0V	
trr	Reverse Recovery Time		160		nS	VGS=0V	
Qrr	Reverse Recovery Charge		0.46		uC	IS=35A di/dt=100A/μs	

Notes:

- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 380µs, Duty Cycle \leq 2%



Typical Feature Curve



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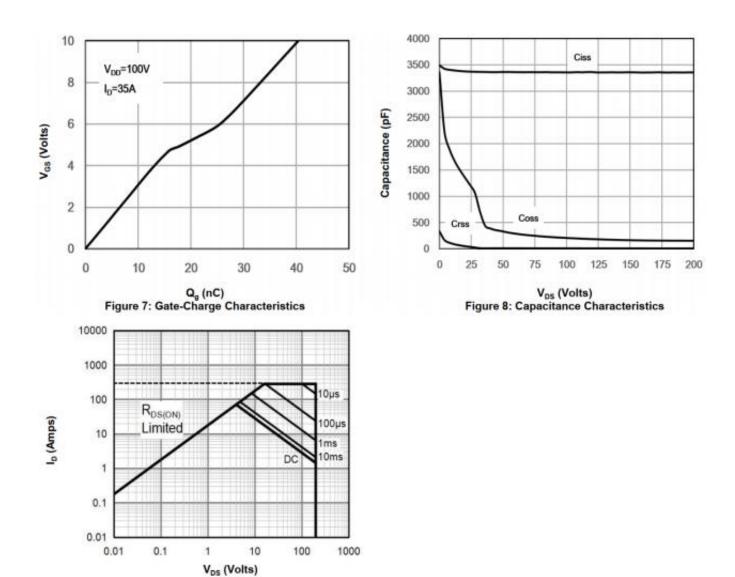
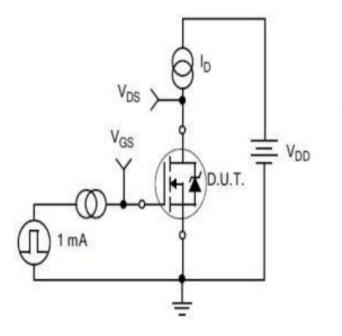


Figure 9: Maximum Forward Biased Safe Operating Area



Test ircuits and Waveforms



VGS(TH)

VDS

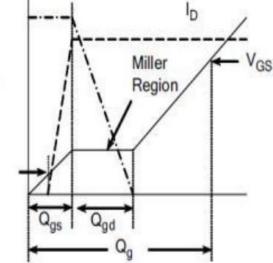


Figure A. Gate Charge Test Circuit

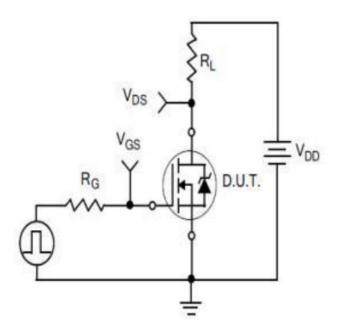


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

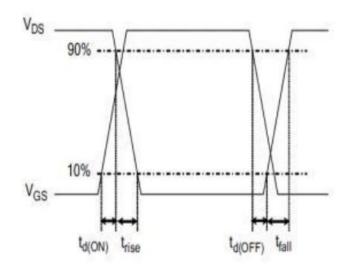
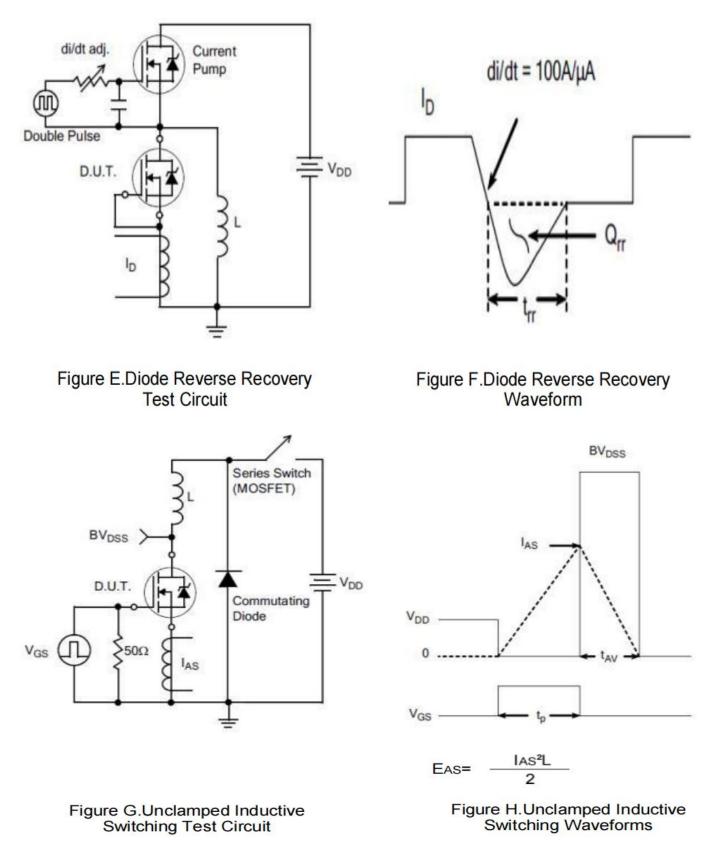


Figure D. Resistive Switching Waveforms

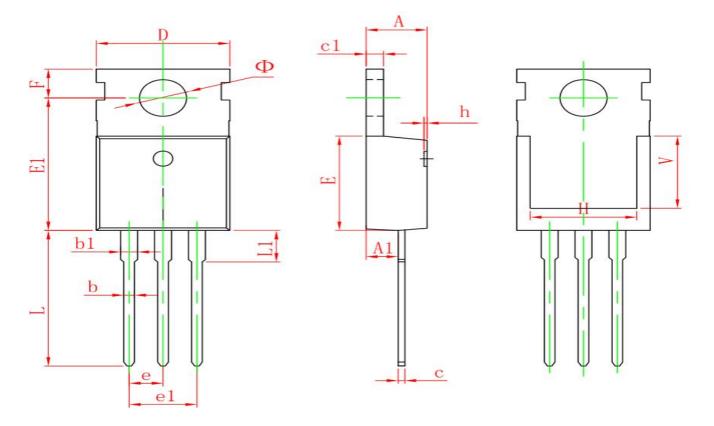


Test ircuits and Waveforms





Package outline drawing(TO-220 Unit: mm)



Symbol	Dimensions	In Millimeters	Dimension	s in inches
Symbol	Min.	Max.	Min.	Max.
A	4.400	4.600	0.173	0.181
A1	2.250	2.550	0.089	0.100
b	0.710	0.910	0.028	0.036
b1	1.170	1.370	0.046	0.054
С	0.330	0.650	0.013	0.026
c1	1.200	1.400	0.047	0.055
D	9.910	10.250	0.390	0.404
E	8.950	9.750	0.352	0.384
E1	12.650	13.050	0.498	0.514
е	2.540	TYP.	0.100	TYP.
e1	4.980	5.180	0.196	0.204
F	2.650	2.950	0.104	0.116
Н	7.900	8.100	0.311	0.319
h	0.000	0.300	0.000	0.012
L	12.900	13.400	0.508	0.528
L1	2.850	3.250	0.112	0.128
V	6.900	REF.	0.276	REF.
Ф	3.400	3.800	0.134	0.150



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